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#### DEVICE SPECIFICATIONS

# PXIe-6556

#### 200 MHz Digital Waveform Generator/Analyzer with PPMU

This document provides the specifications for the PXIe-6556.



**Hot Surface** If the PXIe-6556 has been in use, it may exceed safe handling temperatures and cause burns. Allow the PXIe-6556 to cool before removing it from the chassis.



**Note** All values were obtained using a 1 m cable (SHC68-C68-D4 recommended). Performance specifications are not guaranteed when using longer cables.

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## **Definitions and Conditions**

Specifications are valid for the range 0 °C to 45 °C unless otherwise noted.

Accuracy specifications are valid within ±5 °C of self-calibration unless otherwise noted.

*Maximum* and *minimum* specifications are warranted not to exceed these values within certain operating conditions and include the effects of temperature and uncertainty unless otherwise noted.

*Typical* specifications are unwarranted values that are representative of a majority  $(3\sigma)$  of units within certain operating conditions and include the effects of temperature and uncertainty unless otherwise noted.

*Characteristic* specifications are unwarranted values that are representative of an average unit operating at room temperature.

*Nominal* specifications are unwarranted values that are relevant to the use of the product and convey the expected performance of the product.

All specifications are Typical unless otherwise noted.

## Channels

24, per-pin parametric measurement unit (PPMU)–enabled Per channel attern memory.
attern memory.
PFI 1 PFI 2 PFI 4/DDC CLK OUT PFI 5/STROBE
PFI 0 PFI 3 PFI <2431>
Per channel
4
2
28



Note All PPMU-enabled channels have remote sense capability.

**Related Information** *CLK IN* on page 25 *CLK OUT* on page 27

#### **Digital Generation Channels**



Note These features are controlled independently per channel.

Channels	DIO <023> PFI 1 PFI 2 PFI 4 PFI 5
Generation signal type	Single-ended, ground-referenced
Programmable generation voltage levels	Drive voltage high level ( $V_{OH}$ ) Drive voltage low level ( $V_{OL}$ ) Drive tristate ( $V_{TT}$ )
Generation voltage	
Ranges	Software-selectable: -2 V to 6 V (default) or -1 V to 7 V
Resolution	122 μV
DC generation voltage accuracy <sup>1</sup>	
Within ±5 °C of self-calibration	±11 mV
Within ±15 °C of self-calibration	±16 mV
Generation voltage swing <sup>2</sup>	400 mV to 8.0 V
Output impedance	50 $\Omega$ , nominal
Maximum allowed DC drive strength per channel	±35 mA, nominal



**Caution** Do not exceed the maximum power limit of the device.

Data channel tristate control	Software-selectable, hardware-timed: per channel, per cycle
Channel power-on state	Drivers disabled, high impedance

<sup>&</sup>lt;sup>1</sup> Maximum accuracy when operating within the specified self-calibration temperature range.

 $<sup>^2\,</sup>$  Into a 1 M\Omega load. Power limitations may restrict the number of channels toggling at full voltage swing.

Output protection	
Range	-3 V to 8.5 V
Duration	Indefinite if maximum allowed DC drive
	strength of $\pm 35$ mA per channel is observed

#### **Digital Acquisition Channels**



**Note** These features are controlled independently per channel.

Channels	DIO <023> PFI 1 PFI 2 PFI 4 PFI 5
Acquisition signal type	Single-ended, ground-referenced
Programmable acquisition voltages	Compare voltage high threshold (V <sub>IH</sub> ) Compare voltage low threshold (V <sub>IL</sub> ) Termination voltage (V <sub>TT</sub> )
Acquisition voltage threshold range	-2 V to 7 V
Acquisition and termination voltage resolution	122 μV
Termination voltage ranges	-2 V to 6 V (default) -1 V to 7 V
DC acquisition voltage accuracy <sup>3</sup>	
Within ±5 °C of self-calibration	$V_{IL} = \pm 25 \text{ mV}$ $V_{IH} = \pm 25 \text{ mV}$ $V_{TT} = \pm 11 \text{ mV}$
Within ±15 °C of self-calibration	$V_{IL} = \pm 28 \text{ mV}$ $V_{IH} = \pm 28 \text{ mV}$ $V_{TT} = \pm 16 \text{ mV}$
Minimum detectable voltage swing	50 mV
Input impedance	Software-selectable: High-impedance or 50 $\Omega$ terminated into V <sub>TT</sub>
High impedance leakage	<5 nA, characteristic

 $<sup>^3\,</sup>$  Maximum accuracy when operating within the specified self-calibration temperature range between  $\,$  -1.5 V and 6.8 V.

Input protection	
Range	-3 V to 8.5 V
Duration	Indefinite if maximum allowed DC drive
	strength of $\pm 35$ mA per channel is observed

#### Active Load Channels



**Note** These features are controlled independently per channel.

Channels	Data <023> PFI 1 PFI 2 PFI 4 PFI 5
Programmable levels	Commutating voltage (V <sub>TT</sub> ) Current source (I <sub>SOURCE</sub> ) Current sink (I <sub>SINK</sub> )
Load <sup>4</sup>	
Range	1.5 mA to 24 mA
Resolution	488 nA
Accuracy, ±15 °C of self-calibration	±1 mA

#### **PPMU** Channels

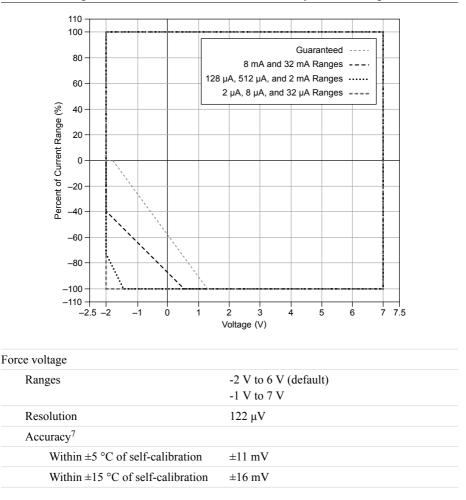
Note These features are controlled independently per channel.

Channels	DIO <023> PFI 1 PFI 2 PFI 4 PFI 5
PPMU signal type <sup>5</sup>	Single-ended, ground-referenced
Programmable levels <sup>6</sup>	Force voltage (F <sub>V</sub> ) Force current (F <sub>I</sub> ) Voltage clamp high (V <sub>CHI</sub> ) Voltage clamp low (V <sub>CLO</sub> )

<sup>&</sup>lt;sup>4</sup> Typical accuracy with 3 V overdrive.

<sup>&</sup>lt;sup>5</sup> Referenced to the ground pins on the VHDCI connector.

<sup>&</sup>lt;sup>6</sup> Voltage clamps are only active when forcing current.



#### Table 1. Force Voltage Settling Time

Current Range	Settling Time <sup>8</sup>
2 μΑ	150 μs
8 μΑ	75 μs

<sup>&</sup>lt;sup>7</sup> Maximum accuracy at the sense location.

<sup>&</sup>lt;sup>8</sup> Settled to 1% of the final value. 1 V steps with 50% of the current range load into 100 pF.

Current Range	Settling Time <sup>8</sup>
32 µA	
128 μΑ	40 μs
512 μΑ	
2 mA	45 μs
8 mA	55 μs
32 mA	60 µs

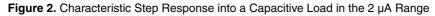
Table 1. Force Voltage Settling Time (Continued)

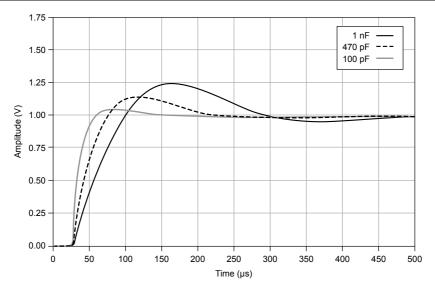
Current Range	Load Capacitance <sup>9</sup>
2 μΑ	1
8 μΑ	
32 µА	1 nF
128 μΑ	
512 μΑ	4.7 nF
2 mA	10 nF
8 mA	47 nF
32 mA	100 nF

<sup>&</sup>lt;sup>8</sup> Settled to 1% of the final value. 1 V steps with 50% of the current range load into 100 pF.

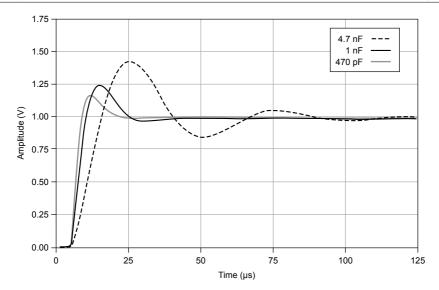
<sup>&</sup>lt;sup>9</sup> These values represent the allowed load capacitance through a 1 m SHC68-C68-D4 cable to ensure a well-behaved transient response.

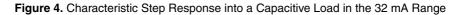
#### Characteristic Step Response

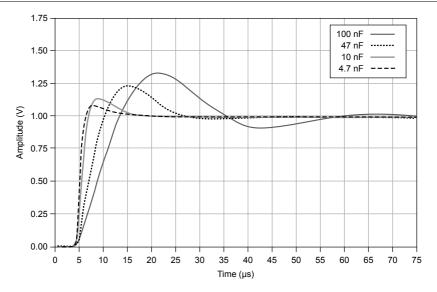












Resolution	
60 pA	
240 pA	
980 pA	
3.9 nA	
15.6 nA	
60 nA	
240 nA	
980 nA	

Table 3. Force Current Resolution, Nominal

Force current accuracy

Within $\pm 5$ °C of self-calibration	1% of range, maximum
Within $\pm 15$ °C of self-calibration	1.3% of range, maximum

#### Force current voltage clamps, maximum

Current range <sup>10</sup>	
V <sub>CLO</sub>	-2 V to 6 V, maximum
V <sub>CHI</sub>	-1 V to 7 V, maximum
Resolution	122 μV, maximum
Accuracy within ±15 °C of self- calibration	±100 mV, maximum



Note Voltage clamps begin to conduct within 700 mV of the programmable voltage level.

Aperture time

Range	4 µs to 65 ms
Resolution	4 μs
Measure voltage <sup>11</sup>	
Range	-2 V to 7 V
Resolution	228 µV
Accuracy within $\pm 15$ °C of self- calibration	±3 mV

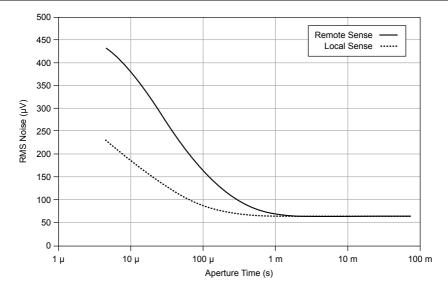


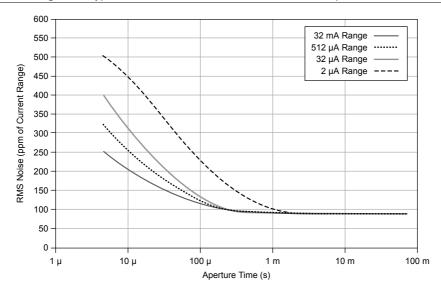
Table 4. Measure Current Resolution, Nominal

Current Range	Resolution
±2 μA	460 pA
±8 µA	1.8 nA
±32 μA	7.3 nA
±128 μA	30 nA
±512 μA	120 nA
±2 mA	460 nA
±8 mA	1.8 μΑ
±32 mA	7.3 μΑ

Measure current accuracy<sup>12</sup>

Within ±5 °C of self-calibration	1% of range
Within ±15 °C of self-calibration	1.3% of range

<sup>12</sup> Maximum accuracy with one 60 Hz PLC aperture.



E

**Note**  $I_{RMS}$  Noise is represented by the following equation:  $I_{rms}$  Noise = (rms Noise × Current Range)/10<sup>6</sup>. For example, 100 ppm on a 32 mA range yields a noise of 3.2  $\mu$ A<sub>rms</sub>, which is calculated as 3.2  $\mu$ A<sub>rms</sub> = (100 ppm × 32 mA)/10<sup>6</sup>.

I/O switch resistance	5.5 $\Omega$ , nominal
Remote feedback impedance	100 kΩ, nominal
Output protection	
Range	-3 V to 8.5 V
Duration	Indefinite if maximum allowed DC drive strength of $\pm 35$ mA per channel is observed

#### **General PFI Channels**

Channels	PFI 0 PFI 3 PFI - 21 - 21
Circuit type	PFI <2431>
PFI 0 and PFI 3	High-speed I/O circuits
PFI <2431>	5 V compatible I/O circuits

Low voltage levels, characteristic 0 V, nominal High voltage levels, characteristic 3.3 V, nominal Drive strength PFI 0 and PFI 3  $\pm 33 \text{ mA}$ PFI <24...31>  $\pm 85 \text{ mA}$ Output impedance 50  $\Omega$ , nominal Output protection 0 V to 5 V Range Indefinite Duration Acquisition voltage level Low thresholds 0.8 V, nominal High thresholds 2 V, nominal Input protection PFI 0 and PFI 3 -1 V to 5 V, maximum PFI <24..31> -1 V to 6.5 V, maximum

# EXTERNAL FORCE and EXTERNAL SENSE Channels

**Note** These specifications are valid for the EXTERNAL FORCE and EXTERNAL SENSE channels on the AUX I/O connector and on the REMOTE SENSE connector. The AUX I/O connector is available only on PXIe-6556 devices.

EXTERNAL FORCE	
Direction	Input
Analog bandwidth	3 MHz, characteristic with a single channel connected
Maximum current	±32 mA
Range	-2 V to 7 V
EXTERNAL SENSE	
Direction	Output
Analog bandwidth	30 kHz, characteristic with a single channel connected
Range	-2 V to 7 V

Generation voltage level

-3 V to 8.5 V
Indefinite if maximum allowed DC drive strength of $\pm 35$ mA per channel is observed

#### **CAL** Channels

These specifications are valid for the CAL channel on the AUX I/O connector and on the REMOTE SENSE connector. The AUX I/O connector is available only on PXIe-6556 devices.

Direction	Output <sup>13</sup>
Voltage level	5 V, nominal
Drive strength	1 mA <sup>14</sup>

## Timing

Sample Clock	
Sources	<ol> <li>On Board clock (internal)</li> <li>CLK IN (SMA jack connector)</li> <li>PXIe_DStarA (PXI Express backplane)</li> <li>STROBE (acquisition only; Digital Data &amp; Control [DDC] connector)</li> </ol>
On Board clock frequency <sup>15</sup>	
Resolution	<0.1 Hz
Accuracy <sup>16</sup>	±150 ppm, nominal
Frequency ranges	
On Board clock	800 Hz to 200 MHz
CLK IN	20 kHz to 200 MHz
PXIe_DStarA	800 Hz to 200 MHz
STROBE	800 Hz to 200 MHz

<sup>&</sup>lt;sup>13</sup> During external calibration. During normal operation, this channel is in a high-impedance or an undriven state.

<sup>&</sup>lt;sup>14</sup> Maximum allowed. Sourcing only.

<sup>&</sup>lt;sup>15</sup> Query NI-HSDIO for the programmed frequency value.

<sup>&</sup>lt;sup>16</sup> Increase accuracy by using a higher performance external Reference clock.

Relative delay adjustment

Range	±5 ns
Resolution	3.125 ps

 $\bigcirc$ 

**Tip** To align multiple devices, apply a delay or phase adjustment to the On Board clock.

Exported Sample clock destinations

1. DDC CLK OUT (DDC connector) 2. CLK OUT (SMA jack connector)

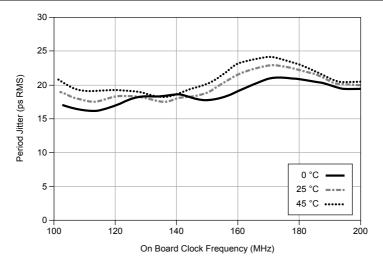


**Note** Internal Sample clocks with sources other than STROBE can be exported.

Exported Sample clock

Offset range (t <sub>CO</sub> )	Software-programmable: 0 ns to 2.4 ns
Offset resolution (t <sub>CO</sub> )	Software-programmable: 13 ps
Offset accuracy (t <sub>CO</sub> )	Software-programmable: ±200 ps
Duty cycle (DDC CLK OUT) <sup>17</sup>	42%, minimum 55%, maximum
Period jitter	24 ps <sub>rms</sub> , characteristic (using On Board clock)

<sup>&</sup>lt;sup>17</sup> 3.3 V at maximum clock rate (200 MHz), not including the effects of system crosstalk.



#### **Related Information**

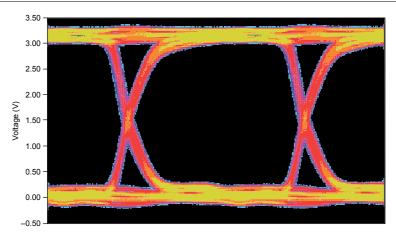
CLK IN on page 25 PXIe\_DStarA on page 27 PFI 5 as STROBE on page 26

#### **Generation Timing**

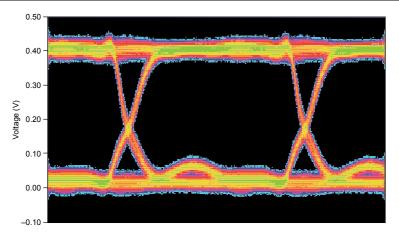
Channels	Data DDC CLK OUT PFI <03>
Maximum data rate per channel	200 Mbps
Maximum data channel toggle rate <sup>18</sup>	
3.3 V swing	100 MHz
5 V swing	50 MHz

The following figure shows an eye diagram of a 200 Mbps pseudorandom bit sequence (PRBS) waveform at 3.3 V. This waveform was captured on a characteristic DIO channel at room temperature into high-impedance.

<sup>&</sup>lt;sup>18</sup> Toggle rates exceeding these values may invalidate CE certifications.



The following figure shows an eye diagram of a 200 Mbps PRBS waveform at 0.4 V. This waveform was captured on a characteristic DIO channel at room temperature into high-impedance.



Data channel-to-channel skew

600 ps, maximum 300 ps, characteristic



**Note** There will be additional skew from crosstalk, acquisition threshold, and other transmission line effects in your system. You may see up to 150 ps of additional skew from differences between channels in the average rate of pattern transitions.

Data position modes	Sample clock rising edge
	Sample clock falling edge
	Delay from Sample clock rising edge
Generation data	
Frequency	
On Board clock	All supported frequencies
External clock	Frequencies ≥20 MHz
Delay range	-1 to 2 Sample clock cycles, expressed as a fraction of the Sample clock period
Deskew range	-2 to 3 Sample clock cycles, expressed as a time in seconds
Delay and deskew resolution	30 ps, nominal



**Note** The sum of data delay and data deskew may not exceed -2 to 3 Sample clock cycles.

#### Generation Provided Setup and Hold Times

Provided setup and hold times assume the data position is set to Sample clock rising edge and the noninverted Sample clock is exported to the DDC connector with  $t_{CO}$  programmed using exported Sample clock offset.

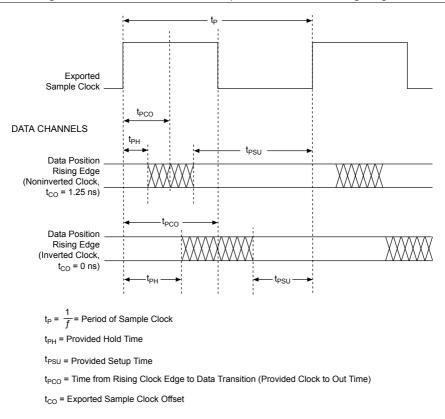
Provided setup time (t <sub>PSU</sub> )	$t_p$ - $t_{CO}$ - 850 ps, characteristic
Provided hold time (t <sub>PH</sub> )	t <sub>CO</sub> - 700 ps, characteristic



 $\label{eq:state} \textbf{Note} \quad \text{Exported Sample clock Offset} \ (t_{CO}) \ is \ software \ programmable.$ 

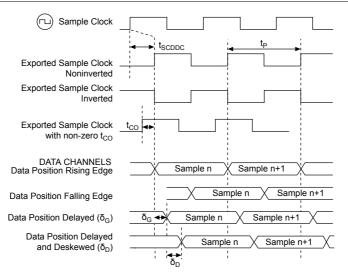
Compare the setup and hold times from the datasheet of your device under test (DUT) to the provided setup and hold time values above. The provided setup and hold times must be greater than the setup and hold times required for the DUT. If you require more setup time, configure your exported Sample clock mode to Inverted and/or delay your clock or data relative to the Sample clock.

The following figure illustrates the relationship between the exported Sample clock mode and the provided setup and hold times.





**Note** Provided setup and hold times account for maximum channel-to-channel skew and jitter.



t<sub>SCDDC</sub> : Time Delay from Sample Clock (Internal) to DDC Connector

 $-1 \le \delta_G \le 2$ : Pattern Generation Channel Data Delay (Fraction of t<sub>P</sub>)

 $t_{\rm P} = \frac{1}{f}$  = Period of Sample Clock

t<sub>CO</sub> = Exported Sample Clock Offset

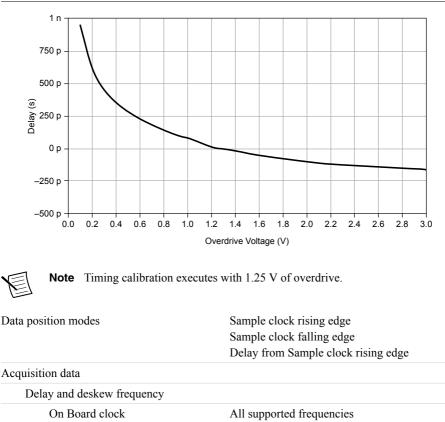
 $\delta_D$  = Pattern Generation Channel Deskew (Time)

#### Acquisition Timing

Channels	Data STROBE PFI <03>
Maximum data rate per channel	200 Mbps
Channel-to-channel skew	600 ps, maximum 300 ps, characteristic



**Note** There will be additional skew from crosstalk, acquisition threshold, overdrive, dispersion, and transmission line effects. You may see up to 175 ps of additional skew from differences between channels in the average rate of pattern transitions.





External clock

Delay and deskew resolution

Delay range

Deskew range

**Note** The sum of data delay and data deskew may not exceed -2 to 3 Sample clock cycles.

30 ps

time in seconds

Frequencies ≥20 MHz

-1 to 2 Sample clock cycles, expressed as a

-2 to 3 Sample clock cycles, expressed as a

fraction of the Sample clock period

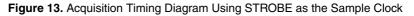
#### Setup and Hold Times to STROBE

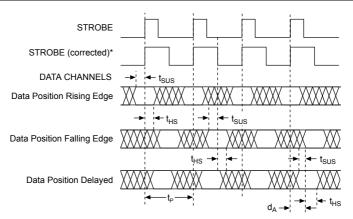
Setup time to STROBE $(t_{SUS})$		
<i>f</i> <20 MHz	2.2 ns	
$f \ge 20 \text{ MHz}$	1.86 ns	
Hold time to STROBE (t <sub>HS</sub> )		
<i>f</i> <20 MHz	3.47 ns	
$f \ge 20 \text{ MHz}$	1.49 ns	



**Note** Setup and hold times include maximum data channel-to-channel skew but do not include system crosstalk. 1.65 V overdrive on all channels. Overall performance may vary with system crosstalk performance. Values are specified within  $\pm 15$  °C of self-calibration.

The following diagram illustrates the relationship between the exported Sample clock mode and the setup and hold times to STROBE.





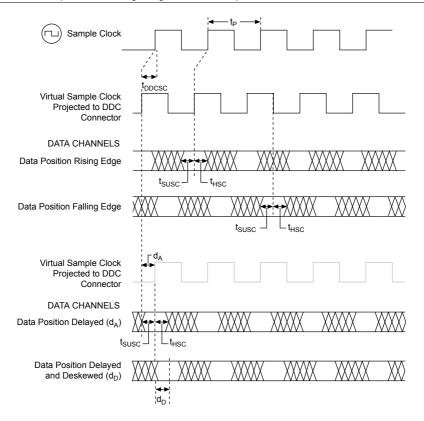
 $t_{SUS}$  = Setup Time to STROBE

 $t_{HS}$  = Hold Time from STROBE

 $-1 \le d_A \le 2$ : Acquisition Data Delay (fraction of  $t_P$ )

 $t_{\rm P} = \frac{1}{f}$  = Sample Clock Period

\*Note: When using an external Sample clock greater than 20 MHz, the duty cycle is corrected to 50%.



$$\begin{split} t_{DCSC} &: \text{Time Delay from DDC Connector or to Internal Sample Clock} \\ -1 &\leq \delta_A &\leq 2 : \text{Pattern Acquisition Channel Data Delay (Fraction of t_P)} \\ t_P &= \frac{1}{f} = \text{Period of Sample Clock} \end{split}$$

t<sub>SUSC</sub> = Setup Time to Sample Clock

t<sub>HSC</sub> = Hold Time to Sample Clock

 $\delta_D$  = Pattern Acquisition Channel Deskew (Time)

#### CLK IN

Connector	SMA jack
Direction	Input
Destinations	<ol> <li>Reference clock (for the phase-locked loop [PLL])</li> <li>Sample clock</li> </ol>

Input

mput	
Coupling	AC
Protection	±10 VDC, nominal
Impedance	Software-selectable: 50 $\Omega$ (default) or 1 k $\Omega$ , nominal
Minimum detectable pulse width	2 ns
Clock requirements	Free-running (continuous) clock
Clock square wave ranges <sup>19</sup>	
Voltage	300 mV <sub>pk-pk</sub> to 5.5 V <sub>pk-pk</sub> , nominal
Frequency	20 kHz to 200 MHz, nominal
Duty cycle	40% to 60%, nominal
Clock sine wave ranges	
0 dBm	
Voltage	630 mV <sub>pk-pk</sub> to 5.5 V <sub>pk-pk</sub>
Frequency	10 MHz to 200 MHz
6 dBm	
Voltage	1.265 $V_{pk-pk}$ to 5.5 $V_{pk-pk}$
Frequency	5 MHz to 200 MHz
12 dBm	
Voltage	2.53 $V_{pk-pk}$ to 5.5 $V_{pk-pk}$
Frequency	2.5 MHz to 200 MHz
PFI 5 as STROBE	
Connector	DDC
Direction	Input
Destination	Sample clock (acquisition only)

800 Hz to 200 MHz

Frequency range

 $<sup>^{19}~</sup>$  3 dB cutoff point at 125 MHz when using 1 k $\Omega$  input impedance.

Duty cycle range<sup>20</sup>

f <20 MHz

 $f \ge 20 \text{ MHz}$ 

25% to 75% 40% to 60%



**Note** STROBE duty cycle is corrected to 50% at  $f \ge 20$  MHz.

Minimum detectable pulse width <sup>20</sup>	2 ns
Clock requirements	Free-running (continuous) clock
Related Information	

#### Related Information

Digital Acquisition Channels on page 5

#### PXIe\_DStarA

Connector	PXI Express backplane	
Direction	Input	
Destinations	<ol> <li>Reference clock (for the PLL)</li> <li>Sample clock</li> </ol>	
Frequency range	800 Hz to 200 MHz	
Duty cycle range	40% to 60%	
Clock requirements	Free-running (continuous) clock	

#### CLK OUT

Connector	SMA jack	
Direction	Output	
Sources	<ol> <li>Sample clock (excluding STROBE)</li> <li>Reference clock (PLL)</li> </ol>	
Generation voltage level <sup>21</sup>		
Low voltage levels, characteristic	0 V, nominal	
High voltage levels, characteristic	3.3 V, nominal	
Drive strength	±33 mA	
Output impedance	50 Ω, nominal	

 $<sup>^{20}\;</sup>$  At the programmed voltage input high (V\_{IH}) threshold.

<sup>&</sup>lt;sup>21</sup> For the low and high generation voltage levels representative of an average unit operating at room temperature.

Output protecti	lon
-----------------	-----

Range0 V and 5 VDurationIndefinite

#### PFI 4 as DDC CLK OUT

Connector	DDC
Direction	Output
Source	Sample clock (generation only)

E

Note STROBE and acquisition Sample clock cannot be routed to DDC CLK OUT.

#### **Related Information**

Digital Generation Channels on page 4

#### Reference Clock (PLL)

Sources <sup>22</sup>	<ol> <li>PXI_CLK100 (PXI Express backplane)</li> <li>CLK IN (SMA jack connector)</li> <li>PXIe_DStarA (PXI Express backplane)</li> <li>None (internal oscillator locked to an internal reference)</li> </ol>	
Frequency		
Range	5 MHz to 100 MHz (integer multiples of 1 MHz)	
Accuracy	<5,000 ppm (required accuracy of the external Reference clock source)	
Lock time	≤25 ms, not including software latency	
Duty cycle range	40% to 60%	
Destination	CLK OUT (SMA jack connector)	

<sup>&</sup>lt;sup>22</sup> Provides the reference frequency for the PLL.

Memory architecture

#### Memory and Scripting

The PXIe-6556 uses the Synchronization and Memory Core (SMC) technology in which waveforms and instructions share onboard memory. Parameters such as number of script instructions, maximum number of waveforms in memory, and number of samples available for waveform storage are flexible and user defined.

Onboard memory size <sup>23</sup>		
8 Mbit/channel		
Acquisition	8 Mbit/channel (32 MBytes total)	
Generation	8 Mbit/channel (32 MBytes total)	
64 Mbit/channel		
Acquisition	64 Mbit/channel (256 MBytes total)	
Generation	64 Mbit/channel (256 MBytes total)	
Generation		
Single-waveform mode	Generates a single waveform once, <i>n</i> times, or continuously	
Scripted mode <sup>24</sup>	Generates a simple or complex sequence of waveforms	
Finite repeat count	1 to 16,777,216	
Waveform quantum		
Data width $= 4$	1 sample	
Data width $= 2$	2 samples	
Waveform block size (in physical	memory) <sup>25</sup>	
Data width = 4	32 samples	
Data width = 2	64 samples	

<sup>&</sup>lt;sup>23</sup> Maximum limit for generation sessions assumes no scripting instructions.

<sup>&</sup>lt;sup>24</sup> Use scripts to describe the waveforms to be generated, the order in which the waveforms are generated, how many times the waveforms are generated, and how the device responds to Script triggers.

<sup>&</sup>lt;sup>25</sup> Regardless of waveform size, NI-HSDIO allocates waveforms in blocks of physical memory.

Configuration	Samp	Sample Rate		
	200 MHz	100 MHz		
Single waveform	1 S	1 S		
Continuous waveform	128 S	64 S		
Stepped sequence	128 S	64 S		
Burst sequence	1,056 S	512 S		

Table 5. Generation Minimum Waveform Size, Samples (S)<sup>26</sup>

Acquisition

Minimum record size <sup>27</sup>	1 sample
Record quantum	1 sample
Total records <sup>28</sup>	2,147,483,647
Total pre-Reference trigger samples	0 up to full record
Total post-Reference trigger samples	0 up to full record
Hardware compare	
Error FIFO depth	4,094
Number of unique enable states	255
Maximum speed	200 MHz

#### Triggers

Trigger Types	Sessions	Edge Detection	Level Detection
1. Start	Acquisition and generation	Rising or falling	
2. Pause	Acquisition and generation		High or low
3. Script <03>	Generation	Rising or falling	High or low
4. Reference	Acquisition	Rising or falling	

 <sup>&</sup>lt;sup>26</sup> Sample rate dependent. Increasing sample rate increases minimum waveform size requirement.
 <sup>27</sup> Regardless of waveform size, NI-HSDIO allocates at least 640 bytes for a record.

<sup>&</sup>lt;sup>28</sup> The session should fetch quickly enough that unfetched data is not overwritten.

Trigger Types	Sessions		Edge Detection	Level Detection
5. Advance	Acquisition		Rising or falling	
6. Stop	Generation		Rising or falling	
Sources		1. PF	1. PFI 0 (SMA jack connector)	
		2. PFI <13> (DDC connector)		
		3. PF	I <2431> (DDC cor	nnector)
		4. PXI_TRIG <07> (PXI Express backplane)		
		5. Pa	5. Pattern match (acquisition sessions only)	
		6. So	ftware (user function	call)
		7. Disabled (do not wait for a trigger)		
Destinations		1. PFI 0 (SMA jack connector)		
		2. PF	I <13> (DDC conne	ector)
		3. PF	I <2431> (DDC cor	nnector)
		4. PX	T_TRIG <06> (PXI	Express backplane)
Minimum required trigg	ger pulse width <sup>29</sup>	15 ns		

Note Each trigger can be routed to any destination except the Pause trigger. The Pause trigger cannot be exported.

150 S
220 S
220 S
220 S

Delay from Pause trigger to Pause state and Stop trigger to Done state

Generation sessions	55 Sample clock periods + 300 ns, maximum
Acquisition sessions	Synchronous with the data



Note Use the Data Active event during generation to determine on a sample by sample basis when the device enters the Pause or Done states.

Delay from Start trigger or Script triggers 6 Sample clock periods + 600 ns, maximum to digital data output

 <sup>&</sup>lt;sup>29</sup> Only applies to Digital Edge triggers.
 <sup>30</sup> Maximum number of samples.

#### Events

Event Types	Sessions
1. Marker <02>	Generation
2. Data Active	Generation
3. Ready for Start	Acquisition and generation
4. Ready for Advance	Acquisition
5. End of Record	Acquisition
Destinations <sup>31</sup>	<ol> <li>PFI 0 (SMA jack connector)</li> <li>PFI &lt;13&gt; (DDC connector)</li> <li>PFI &lt;2431&gt; (DDC connector)</li> <li>PXI_TRIG &lt;06&gt; (PXI Express backplane)</li> </ol>
Marker time resolution (placement)	Markers can be placed at any sample

## Calibration

Warm-up time	30 minutes from driver loaded
External calibration interval	1 year

## Software

#### **Driver Software**

Driver support for this device was first available in NI-HSDIO 1.8.1.

NI-HSDIO is an IVI-compliant driver that allows you to configure, control, and calibrate the PXIe-6556. NI-HSDIO provides application programming interfaces for many development environments.

## **Application Software**

NI-HSDIO provides programming interfaces, documentation, and examples for the following application development environments:

- LabVIEW
- LabWindows<sup>™</sup>/CVI<sup>™</sup>
- Measurement Studio

<sup>&</sup>lt;sup>31</sup> Except for the Data Active event, each event can be router to any destination. The Data Active event can be routed only to the PFI channels.

- Microsoft Visual C/C++
- .NET (C# and VB.NET)

#### NI Measurement Automation Explorer

NI Measurement Automation Explorer (MAX) provides interactive configuration and test tools for the PXIe-6556. MAX is included on the NI-HSDIO media.

#### Power

U	Current Draw, by Voltage		Tatal Damas
Usage Profile <sup>32</sup>	3.3 V	12 V	Total Power
3.3 V swing at 200 Mbps	4.1 A	4.5 A	67.5 W
5.0 V swing at 100 Mbps	4.0 A	4.3 A	64.8 W
8.0 V swing at 50 Mbps	3.8 A	4.3 A	64.1 W
3.3 V swing at 100 Mbps with active load set to 24 mA	4.5 A	4.7 A	71.5 W
Device maximums <sup>33</sup>	5.7 A	5.2 A	76 W

## Physical

Dimensions	Dual 3U CompactPCI Express slot, PXI
	Express compatible
	$21.6 \text{ cm} \times 2.0 \text{ cm} \times 13.0 \text{ cm}$
Weight	793 g (28 oz)

<sup>&</sup>lt;sup>32</sup> Typical results are commensurate with an aggressive user application using all data channels into a high-impedance load with active loads disabled (unless otherwise noted) across temperature.

<sup>&</sup>lt;sup>33</sup> Maximum values prior to device shutdown, requiring subsequent reset of the device.

#### I/O Panel Connectors

Signal	Connector Type	Description
CLK IN		External Sample clock, external Reference clock
PFI 0	SMA jack	Events, triggers
CLK OUT		External Sample clock, exported Reference clock
AUX I/O	Combicon	External force, external sense, and analog calibration
REMOTE SENSE	68-pin VHDCI	PPMU remote sensing channels, external force, external sense, analog calibration
Digital Data & Control (DDC)		Digital data channels, PPMU channels, exported Sample clock, STROBE, events, triggers

## Environment

E

**Note** To ensure that the PXIe-6556 cools effectively, follow the guidelines in the *Maintain Forced Air Cooling Note to Users* included with the PXIe-6556 or available at *ni.com/manuals*. The PXIe-6556 is intended for indoor use only.

Operating temperature	0 °C to 45 °C in all NI PXI Express and hybrid NI PXI Express chassis (meets IEC 60068-2-2)
Operating relative humidity	10 to 90% relative humidity, noncondensing (meets IEC 60068-2-56)
Storage temperature	-20 °C to 70 °C (meets IEC 60068-2-2)
Storage relative humidity	5 to 95% relative humidity, noncondensing (meets IEC 60068-2-56)
Operating shock	30 g, half-sine, 11 ms pulse (meets IEC 60068-2-27; test profile developed in accordance with MIL-PRF-28800F)
Operating vibration	5 Hz to 500 Hz, 0.3 g <sub>rms</sub> (meets IEC 60068-2-64)

Storage shock	50 g, half-sine, 11 ms pulse (meets IEC 60068-2-27; test profile developed in accordance with MIL-PRF-28800F)
Storage vibration	5 Hz to 500 Hz, 2.46 g <sub>rms</sub> (meets IEC 60068-2-64; test profile exceeds requirements of MIL-PRF-28800F, Class B)
Altitude	0 to 2,000 m above sea level (at 25 °C ambient temperature)
Pollution degree	2

## **Compliance and Certifications**

#### Safety

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1



**Note** For UL and other safety certifications, refer to the product label or the *Online Product Certification* section.

#### Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



**Note** In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia, and New Zealand (per CISPR 11), Class A equipment is intended for use only in heavy-industrial locations.



**Note** Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.



**Note** For EMC declarations, certifications, and additional information, refer to the *Online Product Certification* section.



**Caution** Refer to the *Read Me First: Safety and Electromagnetic Compatibility* document for important safety and electromagnetic compatibility information. To obtain a copy of this document online, visit *ni.com/manuals* and search for the document title.



**Caution** To ensure the specified EMC performance, operate this product only with shielded cables and accessories. Do not use unshielded cables or accessories unless they are installed in a shielded enclosure with properly designed and shielded input/ output ports and connected to the product using a shielded cable. If unshielded cables or accessories are not properly installed and shielded, the EMC specifications for the product are no longer guaranteed.



**Caution** To ensure the specified EMC performance, the length of all I/O cables must be no longer than 3 m (10 ft).



**Caution** To ensure the specified EMC performance, you must install PXI EMC Filler Panels, National Instruments part number 778700-01, in all open chassis slots.

## CE Compliance $C \in$

This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)

#### **Online Product Certification**

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for this product, visit *ni.com/ certification*, search by model number or product line, and click the appropriate link in the Certification column.

#### **Environmental Management**

NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the *Minimize Our Environmental Impact* web page at *ni.com/environment*. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

#### Waste Electrical and Electronic Equipment (WEEE)

**EU Customers** At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit *ni.com/environment/weee*.

#### 电子信息产品污染控制管理办法(中国 RoHS)

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